

# Co-doping effect of Zn and Sb in SnO<sub>2</sub>: Valence stabilization of Sb and expanded solubility limit

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## Abstract

In this study, the co-doping effect of ZnO and Sb<sub>2</sub>O<sub>5</sub> on the solubility limit in SnO<sub>2</sub> was investigated. When ZnO was added to SnO<sub>2</sub>, its solubility limit was around 3 at%, while that of Sb<sub>2</sub>O<sub>5</sub> could not be evaluated due to the severe evaporation of Sb<sub>2</sub>O<sub>5</sub> during sintering. For the co-doping of ZnO and Sb<sub>2</sub>O<sub>5</sub>, the ZnSb<sub>2</sub>O<sub>6</sub> phase was used for the source of Zn and Sb dopants to prevent the evaporation of Sb<sub>2</sub>O<sub>5</sub>. When ZnO and Sb<sub>2</sub>O<sub>5</sub> were co-doped by ZnSb<sub>2</sub>O<sub>6</sub>, the solubility limit expanded to 60 at%. XPS analysis of the Sb revealed that Sb<sup>5+</sup> is stable when Zn is co-doped. The extended solubility limit is explained by electrostatic and strain energy minimization in the lattice.

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**Keywords:** SnO<sub>2</sub>; Co-doping; Solubility limit; Charge compensation; XPS

## 1. Introduction

SnO<sub>2</sub> ceramic is, intrinsically, an n-type semiconductor due to the oxygen deficiencies and has a high energy band gap greater than 3.54 eV. Because of its low resistivity of 10<sup>−3</sup> Ω cm and high transmittance of over 80% in the visible region, SnO<sub>2</sub> is applicable for transparent conducting oxide (TCO) and has been widely used as a transparent heating element, gas-detecting sensor and electrode for electric glass-melting furnaces [1–3].

For the exploitation and tailoring of useful TCO materials, the substitution or doping of cation is one of the most promising methods which can lead to improved optical and electrical properties, modified band gap energy, and others. In the case of In<sub>2</sub>O<sub>3</sub>, for making Sn-doped In<sub>2</sub>O<sub>3</sub> (indium tin oxide), the solubility limit of SnO<sub>2</sub> in In<sub>2</sub>O<sub>3</sub> is about 6–8 at% [4]. While the solubility limit of Zn<sup>2+</sup> in In<sub>2</sub>O<sub>3</sub> is close to 1 at% [5]. These results suggest that the respective solubility limits of Sn<sup>4+</sup> and Zn<sup>2+</sup> in In<sub>2</sub>O<sub>3</sub> are relatively low. However, when Sn<sup>4+</sup> and Zn<sup>2+</sup> are co-doped in In<sub>2</sub>O<sub>3</sub>, an enormous solid solution of Sn<sup>4+</sup> and Zn<sup>2+</sup> was reported [6–8].

When both Sn<sup>4+</sup> and Zn<sup>2+</sup> are substituted with the 1:1 ratio in In<sub>2</sub>O<sub>3</sub>, the total amount of soluble Sn<sup>4+</sup> and Zn<sup>2+</sup> can be expanded up to 40 at%. The reason for this is due to the charge compensation between Sn<sup>4+</sup> and Zn<sup>2+</sup> since Sn and Zn ions have an opposite effective charge with respect to In ions and a charge compensation can be obtained without any defect formation [6–8]. Similarly, when Zn<sup>2+</sup> was added to 20 at% Sn<sup>4+</sup> contained In<sub>2</sub>O<sub>3</sub>, in which a large amount of In<sub>4</sub>Sn<sub>3</sub>O<sub>12</sub> second phase is presented, the amount of the second phase decreased as the content of Zn<sup>2+</sup> increased [9].

The energy necessary in such cases is lower than a case in which there is a charge compensation through defect formation. Consequently, the solubility limit can be extended when two dopants, which have opposite effective charges, are added to a matrix by their mutual effect, when compared with the solubility limit of the addition of a single dopant [9].

The current study examined the co-doping effects of Sb<sup>5+</sup> and Zn<sup>2+</sup> in SnO<sub>2</sub>. The solubility limits of the single dopant Sb<sub>2</sub>O<sub>5</sub> and ZnO were examined. Then Sb and Zn co-doping was carried out. In the case of the simultaneous substitution of Sb<sup>5+</sup> and Zn<sup>2+</sup> for Sn<sup>4+</sup> in SnO<sub>2</sub>, the charge compensation should be considered. So, the ZnSb<sub>2</sub>O<sub>6</sub> phase, which is composed of Zn and Sb with an atomic ratio of 1:2, was synthesized and added to SnO<sub>2</sub>. Since Sb has various valence states and it can affect the charge compensation in co-doped SnO<sub>2</sub>, an XPS study was

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conducted. The extended solubility limit by co-doping was discussed on the basis of electrostatic and strain energy minimization.

## 2. Experimental procedure

SnO<sub>2</sub> (Aldrich Chemical Co., USA, 99.9%), ZnO (Sigma Aldrich, 99.9%, USA) and Sb<sub>2</sub>O<sub>5</sub> (high purity chemicals, 99.9%, Japan) were used as the starting chemicals for the general solid-state reaction method of oxides. Since Sb<sub>2</sub>O<sub>5</sub> melts at the relatively low temperature of 525 °C and easily evaporates during the reaction and/or sintering at high temperature [10], the dopants of Sb<sub>2</sub>O<sub>5</sub> and ZnO were not added directly to the SnO<sub>2</sub>. Instead, the ZnSb<sub>2</sub>O<sub>6</sub> phase, in which Zn and Sb cations are composed of a ratio of 1:2, was synthesized by a solid state reaction route at 600 °C for 2 h. The amount of ZnSb<sub>2</sub>O<sub>6</sub> to SnO<sub>2</sub> was varied with Sn:ZnSb<sub>2</sub> ratios of 90:10, 70:30, 50:50, 30:70 and 10:90, i.e., the  $x$  value in the Sn<sub>1-x</sub>Zn<sub>x/3</sub>Sb<sub>2x/3</sub>O<sub>2</sub> system was changed so that  $x = 0.1, 0.3, 0.5, 0.7$  and  $0.9$ .

The weighed raw powders were wet-ball milled with ethyl alcohol for 24 h. After drying, the powder was formed into pellets by a sequential process of weak uniaxial pressing, followed by cold isostatic pressing (CIP) at 250 MPa. Sintering was conducted at 1300 °C for 2 h in a pure oxygen ambient (O<sub>2</sub>; 99.9%) with a heating rate of 5 °C/min.

The weight loss of the samples during sintering was measured using a DTA/TG (320 & SSC 5200H Disk Station, Seiko, Japan). The microstructure of the specimen surfaces was observed by using a scanning electron microscope (Hitachi, S-4300&EDX-350, Tokyo, Japan). X-ray diffraction with nickel-filtered Cu-K $\alpha$  radiation (Mac Science, M03XHF, Yokohama, Japan) and energy dispersive X-ray analysis (EDXA; Oxford, Model 6587, High Wycombe, UK) were used for phase identification. XPS (ESCALAB 250 XPS spectrometer, VG Scientifics, UK) studies were also conducted to analyze the chemical shift of Antimony in the sintered samples in the range of 550–520 eV at 0.2 eV intervals.

## 3. Results and discussion

In order to determine the respective solubility of Sb<sub>2</sub>O<sub>5</sub> and ZnO in SnO<sub>2</sub>, even though detailed experimental results are not presented, various amounts of the dopants were solely doped in SnO<sub>2</sub> and sintered at 1300 °C for 2 h in oxygen. The powder X-ray diffraction of the sintered samples revealed that, in the case

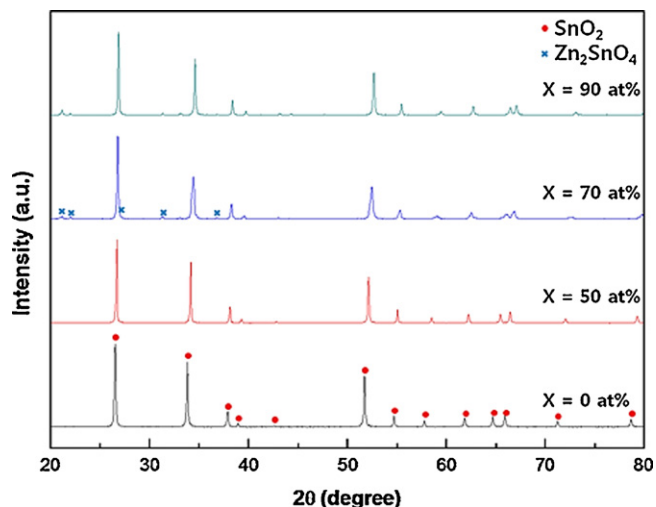


Fig. 1. X-ray diffraction patterns of Sn<sub>1-x</sub>Zn<sub>x/3</sub>Sb<sub>2x/3</sub>O<sub>2</sub> system. Samples were sintered at 1300 °C for 2 h in O<sub>2</sub>.

of the Sb<sub>2</sub>O<sub>5</sub> doping, no diffraction peaks from the second phases were observed and the SnO<sub>2</sub> single phase was maintained even though the amount of Sb<sub>2</sub>O<sub>5</sub> was increased up to 35 at%. On the basis of the weight loss monitored by a DTA/TG, 98–99% of the Sb<sub>2</sub>O<sub>5</sub> evaporated during sintering and it resulted in porous microstructures. The amount of residual Sb in the samples with 10, 20, 30 and 35 at% Sb doped SnO<sub>2</sub> was analyzed by an EDS, and only 0.47, 0.94, 1.20 and 2.40 at% of Sb was found, respectively. In the case of ZnO doping, however, a second phase of Zn<sub>2</sub>SnO<sub>4</sub> (JCPDS no. 24-1470) appeared in the X-ray diffraction when 3 at% of ZnO was doped. Therefore, it is thought that the respective solubility of Sb<sub>2</sub>O<sub>5</sub> and ZnO in SnO<sub>2</sub> is quite small.

On the other hand, the solubility increased greatly when Zn and Sb were co-doped at a 1:2 ratio. Fig. 1 shows the X-ray diffraction patterns of the Sn<sub>1-x</sub>Zn<sub>x/3</sub>Sb<sub>2x/3</sub>O<sub>2</sub> samples as a function of  $x$  which was sintered at 1300 °C for 2 h in oxygen. The single phase of SnO<sub>2</sub> was maintained until  $x = 0.6$  while a small amount of the second phase of the Zn<sub>2</sub>SnO<sub>4</sub> appeared when  $x = 0.7$ . However, it is not reasonable to determine the solubility limit as simply being  $x = 0.7$  when the severe evaporation of Sb is concerned which was previously observed. Table 1 summarizes the cationic compositions of the sintered samples obtained by an EDS analysis. The results yield a tendency that the more ZnSb<sub>2</sub>O<sub>6</sub> dopants, the more the Sb deficiency. The weight loss of the samples after sintering as a function of  $x$  is presented in Fig. 2. The maximum weight loss

Table 1  
A summary of cationic ratios by EDS analysis in sintered Sn<sub>1-x</sub>Zn<sub>x/3</sub>Sb<sub>2x/3</sub>O<sub>2</sub> samples.

Element	$x$				
	$x = 0.1$	$x = 0.3$	$x = 0.5$	$x = 0.7$	$x = 0.9$
	Zn: 3.33 at%	Zn: 10 at%	Zn: 16.7 at%	Zn: 23.3 at%	Zn: 30 at%
	Sb: 6.67 at%	Sb: 20 at%	Sb: 33.3 at%	Sb: 46.7 at%	Sb: 60 at%
Sn L	89.17	69.43	49.29	28.80	9.42
Zn K	4.22	10.95	17.80	29.04	33.65
Sb L	6.61	19.62	32.91	42.15	56.93
Total	100	100	100	99.99	100

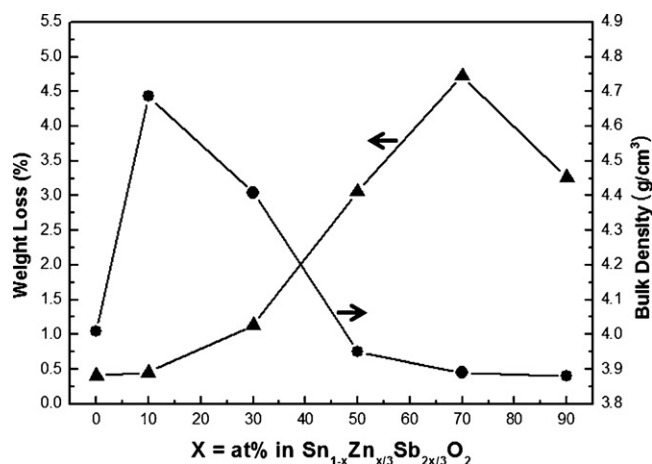


Fig. 2. Weight loss (▲) and bulk density (●) of  $\text{Sn}_{1-x}\text{Zn}_x\text{Sb}_{2x/3}\text{O}_2$  samples.

reached around 4.7% when  $x = 0.7$ . Therefore, it is presumed that the development of the  $\text{Zn}_2\text{SnO}_4$  second phase at  $x = 0.7$  is partly attributed to the Sb evaporation, which induced a charge unbalance between the  $\text{Zn}^{2+}$  and  $\text{Sb}^{5+}$  in  $\text{SnO}_2$ . Note that the amount of Sb evaporation decreased greatly in the  $\text{ZnSb}_2\text{O}_6$  doped samples when compared with the samples doped solely with  $\text{Sb}_2\text{O}_5$ .

Fig. 3 shows the lattice constants of the sintered samples. The solid lines are the lattice constants of the samples calculated and modified on the basis of X-ray diffraction and cationic composition. For a comparison, the lattice constants of  $\text{SnO}_2$  and  $\text{ZnSb}_2\text{O}_6$  are marked and connected with dotted lines to see if the experimental results agree well with Vegard's law.

In order to investigate the valence state of Sb in the sintered samples, an XPS analysis for the raw chemicals of  $\text{Sb}_2\text{O}_5$  and  $\text{Sb}_2\text{O}_3$  (both are the products of the same company) was conducted, and the results are shown in Fig. 4 as a reference. The analysis for  $\text{Sb}_2\text{O}_3$  revealed that the peaks of  $3d_{3/2}$  and  $3d_{5/2}$  appeared at 539.00 eV and 529.65 eV, respectively, which is in agreement with the results found in previous studies [11]. However,  $\text{Sb}_2\text{O}_5$  presents a simultaneous existence of  $\text{Sb}_2\text{O}_5$

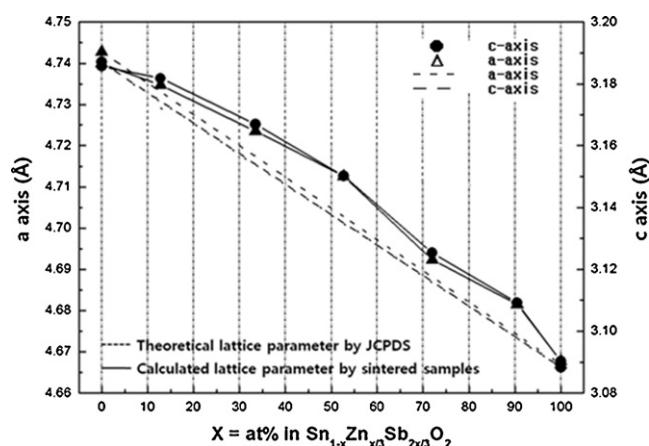


Fig. 3. Lattice constants of  $a$ -axis (▲) and  $c$ -axis (●) of  $\text{Sn}_{1-x}\text{Zn}_x\text{Sb}_{2x/3}\text{O}_2$  samples. Dot lines exhibit theoretical lattice constants evaluated from the values in the JCPDS and solid lines exhibit lattice constants of sintered samples evaluated from the X-ray diffraction.

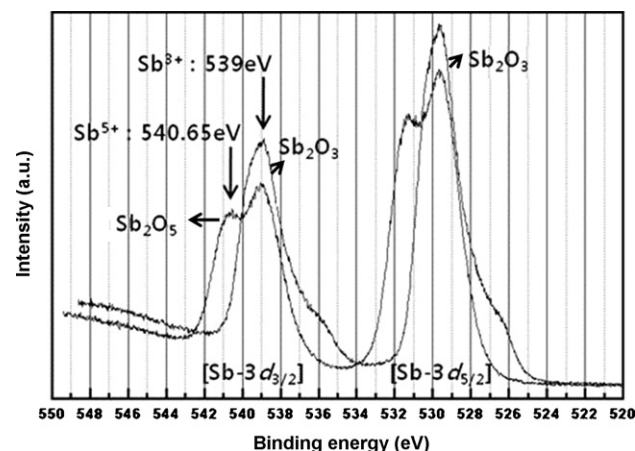


Fig. 4. XPS narrow scan of antimony oxides for a reference.

and  $\text{Sb}_2\text{O}_3$ , showing not only  $3d_{3/2}$  and  $3d_{5/2}$  peaks at 540.65 eV and 531.30 eV, respectively from  $\text{Sb}_2\text{O}_5$  but also  $3d_{3/2}$  and  $3d_{5/2}$  peaks at 529.65 eV and 539.00 eV, respectively from  $\text{Sb}_2\text{O}_3$  [11]. Because  $\text{Sb}_2\text{O}_5$  is known to have a metastable phase at atmospheric pressure [12], both  $\text{Sb}_2\text{O}_5$  and  $\text{Sb}_2\text{O}_3$  exist together as shown in Fig. 4.

Fig. 5 shows the XPS spectra of the sintered samples as a function of the dopants  $\text{Sb}_2\text{O}_5$  and  $\text{ZnO}$  in  $\text{Sn}_{1-x}\text{Zn}_x\text{Sb}_{2x/3}\text{O}_2$  where  $x = 0.1, 0.3$  and  $0.5$ . The results revealed that the peaks for  $\text{Sb-}3d_{3/2}$  and  $3d_{5/2}$  are composed of  $\text{Sb}^{5+}$  only at 540.50 eV and 531.00 eV, respectively, regardless of the amount of dopants and no traces of  $\text{Sb}^{3+}$  were found. The small discrepancy in the peak position less than 0.3 eV between the reference (Fig. 4) and the samples (Fig. 5) is caused by the chemical shift of Sb (binding energy difference in  $\text{Sb}_2\text{O}_5/\text{Sb}_2\text{O}_3$  and  $\text{Sn}_{1-x}\text{Zn}_x\text{Sb}_{2x/3}\text{O}_2$ ).

In the Sn–Sb binary oxide systems, it is reported that the concentration of  $\text{Sb}^{3+}$  and  $\text{Sb}^{5+}$  is competitive when the antimony doping level or annealing temperatures are changed. According to Terrier et al. [13], antimony exists under two oxidation states of  $\text{Sb}^{5+}$  and  $\text{Sb}^{3+}$  in doped  $\text{SnO}_2$  films, and the  $\text{Sb}^{3+}$  component overcomes the  $\text{Sb}^{5+}$  component as the doping level increases. Rockenberger et al. [14] and Jayakumar et al. [15] reported that an annealing temperature dependence of the

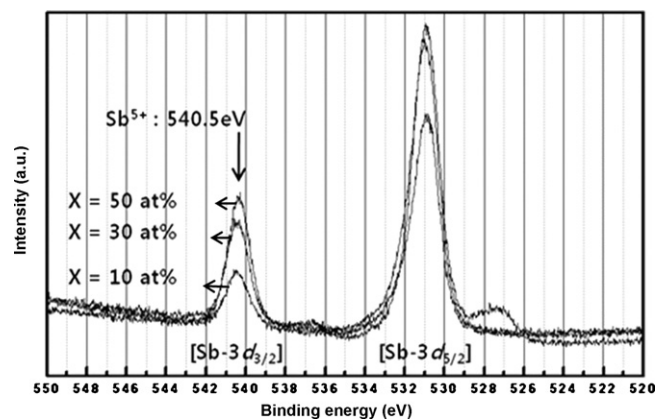
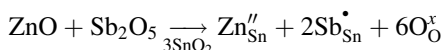


Fig. 5. XPS narrow scan of  $\text{Sn}_{1-x}\text{Zn}_x\text{Sb}_{2x/3}\text{O}_2$ .

valence state that the concentration of  $\text{Sb}^{3+}$  is predominant over 500 °C. These results were explained by a thermodynamic reason whether the valence of Sb is in a stable or metastable atmospheric state [12].

Unlikely to the previous results, we observed only  $\text{Sb}^{5+}$  in the samples in which the charge compensation was satisfied when Zn and Sb are co-doped at the 1:2 ratio. This can be expressed by



In this case, the complete charge compensation is maintained without defect generation and the electrostatic energy can be minimized. On the other hand, concerning the doping induced strain energy in the lattice, since the ionic radius of  $\text{Zn}^{2+}$  (0.074 nm) is larger and  $\text{Sb}^{5+}$  (0.06 nm) is smaller than  $\text{Sn}^{4+}$  (0.069 nm), the strain energy of the lattice will be decreased by the co-doping of  $\text{Zn}^{2+}$  and  $\text{Sb}^{5+}$ . Consequently, from the electrostatic and mechanical energy viewpoint, it is understood that the electrical charge and strain energy compensation by the co-doping extended the solubility limit up to  $x = 0.6$  in  $\text{Sn}_{1-x}\text{Zn}_{x/3}\text{Sb}_{2x/3}\text{O}_2$ .

#### 4. Conclusion

When  $\text{Sb}_2\text{O}_5$  and ZnO were added to  $\text{SnO}_2$ , their respective solubility limits were small. However, when  $\text{ZnSb}_2\text{O}_6$ , which is composed of Zn and Sb with an atomic ratio of 1:2, was doped in  $\text{SnO}_2$ , the solubility limit increased greatly to 60 at%. In this case, the electrostatic energy can be minimized by the charge compensation when Zn and Sb are co-doped with an atomic ratio of 1:2. The XPS analysis of Sb supports the charge compensation between  $\text{Zn}^{2+}$  and  $\text{Sb}^{5+}$  which showed only  $\text{Sb}^{3+}$  in the sample. Furthermore, the strain energy of the lattice can be reduced when  $\text{Zn}^{2+}$  (0.074 nm) and  $\text{Sb}^{5+}$  (0.06 nm) are simultaneously substituted for  $\text{Sn}^{4+}$  (0.069 nm). The extended solubility limit by co-doping was explained by the total energy reduction.

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#### References

- [1] J.G. Fagan, V.R.W. Amarakoon, Am. Ceram. Bull. 72 (3) (1993) 119.
- [2] G. Williams, G.S.V. Coles, The gas-sensing potential of nanocrystalline tin dioxide produced by a laser ablation technique, MRS Bull. 24 (6) (1999) 25–29.
- [3] R.G. Gordon, Criteria for choosing transparent conductors, MRS Bull. 25 (8) (2000) 52–57.
- [4] G. Frank, H. Kostlin, Electrical properties and defect model of tin-doped indium oxide layers, Appl. Phys. A: Solids Surf. 27 (4) (1982) 197–206.
- [5] D.H. Park, K.Y. Son, J.H. Lee, J.J. Kim, J.S. Lee, Effect of ZnO addition in  $\text{In}_2\text{O}_3$  ceramics: defect chemistry and sintering behavior, Solid State Ionics 172 (1–4) (2004) 431–434.
- [6] G.B. Palmer, K.R. Poeppelmeier, T.O. Mason, Conductivity transparency of  $\text{ZnO}/\text{SnO}_2$ -cosubstituted  $\text{In}_2\text{O}_3$ , Chem. Mater. 9 (12) (1997) 3121–3126.
- [7] A. Ambrosini, G.B. Palmer, A. Maignan, K.R. Poeppelmeier, M.A. Lane, P. Brazis, C.R. Kannewurf, T. Hogan, T.O. Mason, Variable-temperature electrical measurements of zinc oxide/tin oxide-cosubstituted indium oxide, Chem. Mater. 14 (1) (2002) 52–57.
- [8] A. Ambrosini, S. Malo, K.R. Poeppelmeier, M.A. Lane, C.R. Kannewurf, T.O. Mason, Zinc doping in cosubstituted  $\text{In}_{2-2x}\text{Sn}_x\text{Zn}_x\text{O}_{3-\delta}$ , Chem. Mater. 14 (1) (2002) 58–63.
- [9] K.H. Seo, D.H. Park, J.H. Lee, J.J. Kim, Co-doping effect of  $\text{SnO}_2$  and ZnO in  $\text{In}_2\text{O}_3$  ceramics: change in solubility limit and electrical properties, Solid State Ionics 177 (5–6) (2006) 601–605.
- [10] G.V. Samsonov, The Oxide Handbook, IFI/Plenum, New York, 1982.
- [11] C.D. Wagner, W.M. Riggs, L.E. Davis, J.F. Moulder, in: G.E. Muilenberg (Ed.), Handbook of X-ray Photoelectron Spectroscopy, Perkin Elmer Co., Minnesota, 1979, pp. 120–121.
- [12] N.A. Asryan, A.S. Alikhanyan, G.D. Nipan, Specifics of sublimation of antimony oxides, Phys. Chem. 392 (2003) 221–226.
- [13] C. Terrier, J.P. Chatelon, J.A. Roger, Analysis of antimony doping in tin oxide thin films obtained by the sol–gel method, J. Sol–Gel. Sci. Technol. 10 (1997) 75–81.
- [14] J. Rockenberger, U. Zum Felde, M. Tischer, L. Troger, M. Haase, H. Weller, Near edge X-ray absorption fine structure measurements (XANES) and extended X-ray absorption fine structure measurements (EXAFS) of the valence state and coordination of antimony in doped nanocrystalline  $\text{SnO}_2$ , J. Chem. Phys. 112 (9) (2000) 4296–4304.
- [15] O.D. Jayakumar, V. Sudarsan, S.K. Kulshreshtha, Metallic nature of  $\text{Sn}_{1-x}\text{Sb}_x\text{O}_{2\pm\delta}$  ( $x = 0.0, 0.10$ , and  $0.20$ ) mixed oxides: probed by  $^{119}\text{Sn}$  MAS NMR, Phys. B 392 (2007) 67–71.